

<b>Notice of References Cited</b>	Application/Control No. 10/633,419	Applicant(s)/Patent Under Reexamination NAKANISHI ET AL.	
	Examiner Jonathan S. Crepeau	Art Unit 1746	Page 1 of 1

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*	B	US-6,531,246	03-2003	Hanafusa et al.	429/162
*	C	US-2002/0146621	10-2002	Yageta et al.	429/181
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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